Sub-diffraction imaging of nitrogen-vacancy centers in diamond by stimulated emission depletion and structured illumination

Xusan Yang, Yan-Kai Tzeng, Zhouyang Zhu, Zhihong Huang, Xuanze Chen, Yujia Liu, Huan-Cheng Chang, Lei Huang, Wen-Di Li, Peng Xi

1. TEM image of the FND nanoparticles

The FND nanoparticles were imaged with transmission electron microscope (H9000, Hitachi, Japan). Since the FND nanoparticles show irregular shape and aspect ratio (Supplementary Figure 1a), the diameters of the short axis are measured and statistically analyzed (Supplementary Figure 1b). The average size of the FNDs is $34.3 \pm 4.2$ nm.

As the resolution is calculated with subtraction of the particle size in two-dimension: $d_{\text{resolution}} = \sqrt{d_{\text{FWHM}}^2 - d_{\text{size}}^2}$, the conservative estimation of the nanoparticle
size can lead to an under-estimation of the resolution enhancement, especially when the resolution is comparable to the particle size.

2. **Emission spectra of the FND nanoparticles and NV centers in bulk diamond**

The excitation spectrum of the 35nm FND was acquired by using an inverted microscope (TCS SP8, Leica, Germany) equipped with a pulsed white light laser system with wavelength of 470–670nm and repetition rate of 78 MHz. The FND was fixed on the coverslip glass by spin coating for optimal spectrum measurement. The excited light was chosen from 470 to 650 nm, and the resolution wavelength is 1 nm. Fluorescence was collected through an oil-immersion objective (63x, NA 1.4) and detected with a GaAsP hybrid detection system at the emission band of 700–800nm. To avoid the background interference, the detection was time-gated from 4 to 12ns.

![Fluorescence spectra of NV center in the fluorescent nanodiamond particle solution (black) and NV dot array patterns (blue) on the bulk diamond.](image)

Emission spectra of FNDs suspended in water were acquired by using a home-built setup in Taiwan, which consists a continuous-wave 532 nm laser (DPGL-2100F, Photop Suwtech), a dichroic mirror (Z532RDC, Chroma), a long-working distance microscope objective (50x, NA 0.55, Mitutoyo), a long-pass edge filter (E550LP, Chroma), and a multichannel analyzer (C7473, Hamamatsu), as previously described
Fluorescence was collected in a backward geometry to prevent strong light scattering loss due to the high refractive index of the FND nanoparticles. The photoluminescence emission spectrum of the NV centers created by focused helium ion beam implantation on the bulk diamond was characterized using a home-built confocal microscope setup in Hewlett-Packard Labs. A 532 nm laser was used to excite the NV centers at room temperature. As NV centers are embedded in the diamond matrix, FND particles from these two sources show essentially the same spectra (Supplementary Figure 2), although the spectrometric measurement of the bulk NV center is limited to 690 nm. The sharp peaks at 575 nm and 638 nm correspond to the zero-phonon lines of neutral and negatively charged NV centers (NV$^0$ and NV$^-$), respectively.

3. Artifact of SIM associated with axial focal displacement

Comparing to conventional wide field microscopy, SIM results (c and f) have a little axial shift which was caused by different wavefront of conventional wide field path and SIM optical path, due to the additional grating and other optical elements in SIM configuration. From (d) and (f), we can see that the three dots in the two images didn’t match well (yellow dotted lines). The pseudo wide-field microscopy result (b and e) generated from the superposition of the 9 SIM frames matched well with the SIM microscopy result (c and f).

Supplementary Figure 3 Imaging of FNDs with conventional wide-field (a and d), the pseudo wide-field
microscopy (b and e) and SIM microscopy (c and f). Magnifications of the boxed areas (yellow) in (a), (b) and (c) were shown in view (d), (e) and (f), respectively. Pixel sizes of the wide-field and SIM microscopy are 60 nm and 30 nm, respectively, and the exposure time is 9 s for each frame. Scale bar, 1 μm.

4. Imaging of mouse kidney with SIM

To demonstrate the capability of our SIM system in biological specimen, a cryostat section of mouse kidney sample (Invitrogen, F24630) stained with Alexa Fluor 488 wheat germ agglutinin, Alexa Fluor 568 phalloidin, and DAPI was used. Alexa Fluor 488 wheat germ agglutinin was used to label elements of the glomeruli and convoluted tubules. Alexa Fluor 568 conjugated to phalloidin was utilized as fluorescent label of the filamentous actin in the brush boarder of the mouse kidney. As can be seen from Supplementary Figure 4 and 5, the resolution of SIM in both cases reaches ~140 nm in both cases, which is ~2-fold improvement over wide-field microscopy, enabling the visualization of the fine structures of the specimen.

**Supplementary Figure 4** Comparison of the wide-field (a) and SIM imaging (b) at 488 nm excitation for the fine structure of the convoluted tubule in the mouse kidney. Magnifications of the boxed areas (yellow) in (a), (b) were shown in (c) and (d), respectively. The intensity along the line in (c) and (d) are plotted in (e). Pixel sizes of the wide-field and SIM microscopy are 60 nm, and the exposure time is 9 s for each frame. Scale bar, 1 μm.
Supplementary Figure 5 Comparison of the wide-field (a) and SIM imaging (b) at 561 nm excitation for the brush border of the mouse kidney. Magnifications of the boxed areas (yellow) in (a), (b) were shown in (c) and (d), respectively. The intensity along the line in (c) and (d) are plotted in (e). Pixel sizes of the wide-field and SIM microscopy are 60 nm and 30 nm, respectively, and the exposure time is 9 s for each frame. Scale bar, 1 μm.